

<b>Notice of References Cited</b>	Application/Control No. 10/805,172	Applicant(s)/Patent Under Reexamination JANNUSCH ET AL.	
	Examiner Tristan J. Mahyera	Art Unit 4173	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,132,113	11-2006	Zerbe et al.	424/439
*	B	US-2003/0118653	06-2003	Chen et al.	424/484
*	C	US-7,153,531	12-2006	Engleson et al.	426/89
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	K	US-			
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**NON-PATENT DOCUMENTS**

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